

Reading assignment:

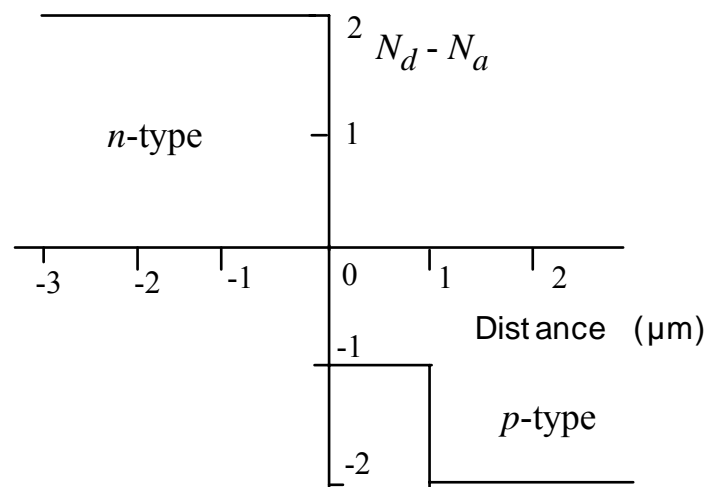
Chapters 3 and 4 of the textbook

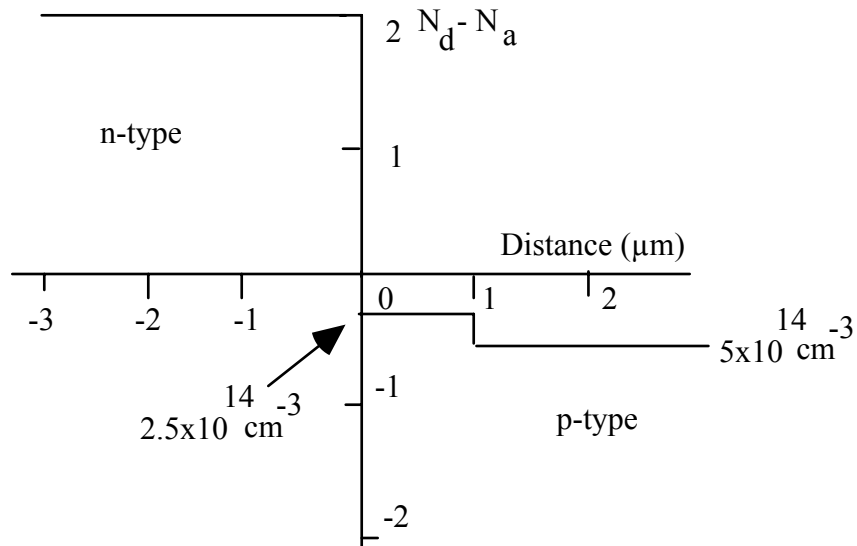
SDM-1 Michael Shur

Homework # 3

1: 20 points/ 2: 20 points. 3: 20 points/ 4: 20 points 5: 20 points

1. Given the built-in voltage, V_{bi} , for a p^+-n junction, derive the equation relating the ratio of the depletion width of the p^+-n junction (at zero bias) over the Debye radius at a given temperature, T . Assume zero bias voltage.
2. Calculate and plot electron and hole concentrations versus distance for a p^+-n silicon junction with the acceptor density in the p -type region, $N_a = 10^{16} \text{ cm}^{-3}$ and with the donor density in the n -type region, $N_d = 10^{14} \text{ cm}^{-3}$ at room temperature and zero bias voltage. The dielectric permittivity of Si is $1.05 \times 10^{-10} \text{ F/m}$. The energy gap of Si is 1.12 eV. The densities of states in the conduction and valence bands at room temperature are $3.22 \times 10^{19} \text{ cm}^{-3}$ and $1.83 \times 10^{19} \text{ cm}^{-3}$, respectively.
3. Sketch the field distributions in a $p-n$ silicon junction with doping profiles shown in the figures. Assume zero applied bias and room temperature ($n_i \approx 10^{10} \text{ cm}^{-3}$). The silicon dielectric permittivity is $1.05 \times 10^{-10} \text{ F/m}$.



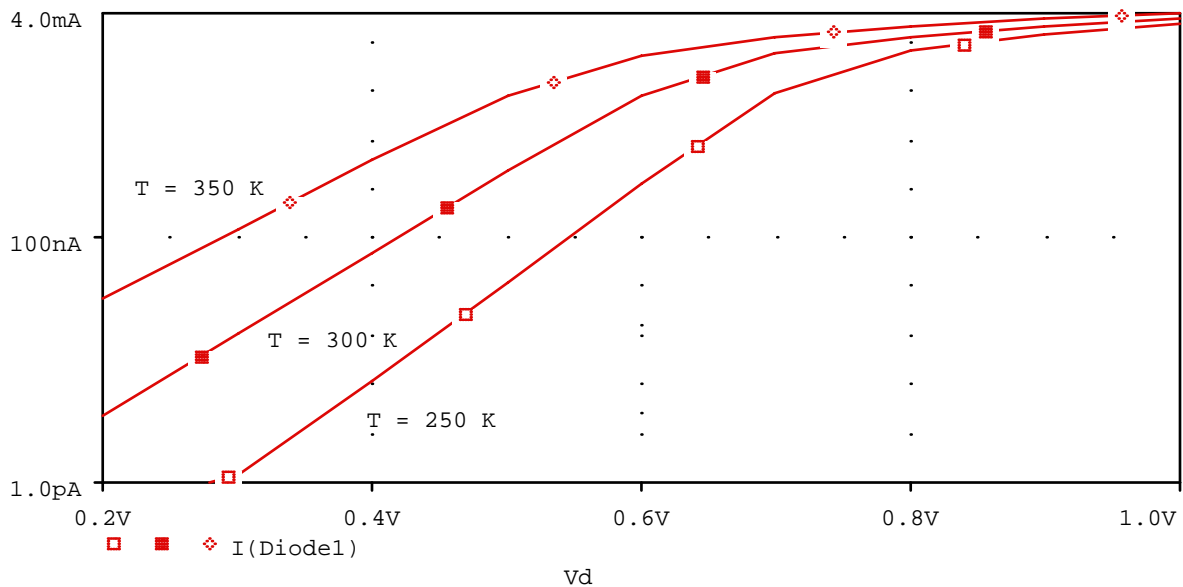


Vertical axis - doping in 10^{15} cm^{-3} . Positive values correspond to *n*-type, negative to *p*-type.

4. From the *I-V* characteristics of the *p-n* junction shown in the figure, estimate the diode saturation current, the ideality factor, and series resistance. Using the following empirical equation for the temperature dependence of the saturation current, estimate the energy gap of the semiconductor material of the diode:

$$I_s(T) = I_s(T_o) \left(\frac{T}{T_o} \right)^{\frac{\kappa}{\eta}} \exp\left(\frac{E_g}{k_B T_o} \right) \exp\left(-\frac{E_g}{k_B T} \right)$$

(Assume that $\kappa/\eta = 0$.)



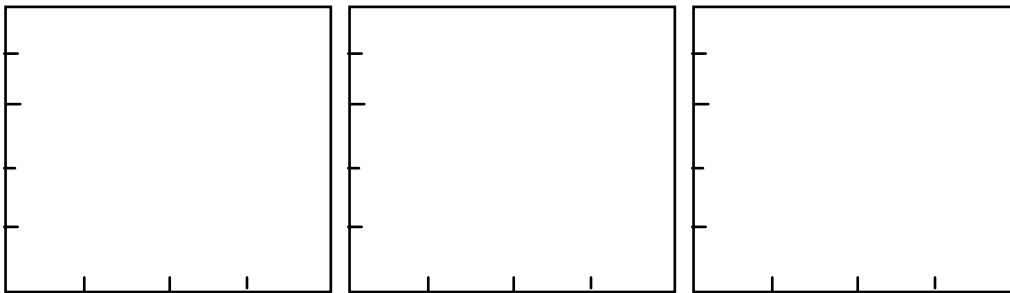
5. /20

. Consider a Si $p-n$ junction with doping of 10^{15} cm^{-3} in both the p -type region and n -type regions. The intrinsic carrier concentration is 10^{10} cm^{-3} . Temperature, $T = 300 \text{ K}$. Silicon dielectric permittivity is $1.05 \times 10^{-10} \text{ F/m}$.

Sketch a band diagram for

- a. zero bias
- b. 0.3 forward bias
- c. 1 volt reverse bias

Show the scales.



Zero bias

Forward bias 0.3 V

Reverse bias 1 V